



CE EMC Test Report

Project No. : 1912H030

Equipment: Children ride on toys

Brand Name : N/A
Test Model : TR1905
Series Model : N/A

Applicant: Jinjianfeng Group Pinghu Children Tricycle Co.,Ltd

Address : North of Babycar Road, Xincang Town, Pinghu City, ZheJiang. China

Factory : Jinjianfeng Group Pinghu Children Tricycle Co.,Ltd

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Date of Receipt : Dec. 17, 2019

Date of Test : Dec. 17, 2019 ~ Jan. 12, 2020

Issued Date : Jan. 21, 2020

Report Version : R00

Test Sample : Engineering Sample No.: SH20191217127, SH2019123143

Standard(s) : EN 55014-1:2017

Antonis. Long

EN 55014-2:2015 EN 61000-3-2:2014 EN 61000-3-3:2013

The above equipment has been tested and found compliance with the requirement of the relative standards by BTL Inc.

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Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective. Please note that the measurement uncertainty is provided for informational purpose only and are not use in determining the Pass/Fail results.



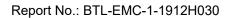
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REPORT ISSUED HISTORY

Report Version	Description	Issued Date
R00	Original Issue.	Jan. 21, 2020



1. SUMMARY OF TEST RESULTS

Test procedures according to the technical standards:

Emission				
Standard	Te	Test Item		
		Mains po	rts	PASS
	Continuous Disturbance	N/A	Voltage	N/A
	voltage/current N/A		Current	N/A
EN 55014-1:2017	Wired network ports		N/A	
	Discontinuous disturbances	Clicks		N/A
	Disturbance power		N/A	
	Radiated disturbances		PASS	

Standard	Test Item	Judgment
EN 61000-3-2:2014	Harmonic current emissions	PASS
EN 61000-3-3:2013	Voltage changes, voltage fluctuations and flicker	PASS

Immunity			
Standard(s)	Ref Standard(s)	Test Item	Result
	IEC 61000-4-2:2008	ESD	PASS
	IEC 61000-4-3: 2006+A1:2007+A2:2010	RS	PASS
EN 55014-2:2015	IEC 61000-4-4:2012	EFT	PASS
EN 33014-2.2013	IEC 61000-4-5:2014+A1:2017	Surge	PASS
	IEC 61000-4-6:2013	CS	PASS
	IEC 61000-4-11:2004+A1:2017	Dips	PASS

NOTE:

(1) " N/A" denotes test is not applicable in this Test Report.



1.1 TEST FACILITY

The test facilities used to collect the test data in this report is located at the location of No. 29, Jintang Road, Tangzhen Industry Park, Pudong New Area, Shanghai 201210, China.

1.2 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2, The BTL measurement uncertainty is less than the CISPR 16-4-2 U_{cispr} requirement.

The reported uncertainty of measurement $\mathbf{y} \pm \mathbf{U}$, where expanded uncertainty \mathbf{U} is based on a standard uncertainty multiplied by a coverage factor of $\mathbf{k}=2$, providing a level of confidence of approximately 95%.

A. Continuous Disturbance voltage/current Measurement:

Test Site	Method	Measurement Frequency Range	U , (dB)
SH C01	CISPR	9 kHz ~ 150 MHz	2.92
SH-C01	CISPR	150 kHz ~ 30 MHz	2.40

B. Radiated disturbances Measurement:

Test Site	Method	Measurement Frequency Range	Ant. H / V	U , (dB)
		30MHz ~ 200MHz	V	3.86
SH-CB01	CISPR	30MHz ~ 200MHz	Н	2.88
(3m)	CISPR	200MHz ~ 1,000MHz	V	3.88
		200MHz ~ 1,000MHz	Н	3.70

C. Harmonic current / Voltage fluctuations (Flicker) measurement:

Test Site	Method	Test item	U(%)
SH-SR03	IEC 61000-3-2	Voltage	0.600
311-31703	IEC 61000-3-3	Current	0.593



D. Immunity Measurement:

D. Immunity	Measurement:		
•		Rise time tr	5.0%
SH-SR01 IEC 61000-4-2		Peak current lp	4.8%
		Current at 30 ns	4.8%
		Current at 60 ns	4.8%
		Electromagnetic field immunity test	1.76dB
		On-ear acoustic & Acoustic measurements on	1.78dB
	loudspeakers		1.7 OUD
SH-CB12	IEC 61000-4-3	For electrical measurements / For measuring the	1.76dB
		demodulation on analogue wired network lines	1.7 OUD
		Audio breakthrough measurement for RS 2G/3G	1.86dB
		Audio breakthrough measurement for RS 4G	2.00dB
		voltage peak value(VP)	5.0%
		voltage rise time (tr)	4.0%
		voltage pulse width(tw)	4.0%
	IEC 61000-4-4	Pulse Freq.(kHz)	4.0%
SH-SR02		Burst Duration(ms)	4.0%
		Burst Period(ms)	4.0%
		voltage peak value(VP)-with clamp	5.0%
		voltage rise time (tr) -with clamp	5.0%
		voltage pulse width(tw) -with clamp	3.7%
		Open-Circuit Output Voltage	5.0%
SH-SR02	IEC 61000-4-5	Open-Circuit front time	4.0%
		Open-Circuit time of half value	4.0%
		CDN	1.70dB
		EM clamp test process	3.36dB
		On-ear acoustic & Acoustic measurements on	1.68dB
SH-SR03	IEC 61000-4-6	loudspeakers	1.000D
311-31(03	16001000-4-0	For electrical measurements / For measuring the	1.64dB
		demodulation on analogue wired network lines	
		Audio breakthrough measurement for RS 2G/3G	1.76dB
		Audio breakthrough measurement for RS 4G	1.92dB
SH-SR02	IEC 61000-4-11	DIP Amplitude	5.0%
DIP Time Event		4.0%	

Note: Unless specifically mentioned, the uncertainty of measurement has not been taken into account to declare the compliance or non-compliance to the specification.



1.3 TEST ENVIRONMENT CONDITIONS

Test Item	Temperature	Humidity	Tested By
Continuous Disturbance voltage/current	17°C	49%	Calm Lan
Radiated disturbances	18°C	35%	Martin Yin
Harmonic current	22°C	51%	Sam Cheng
Voltage fluctuations (Flicker)	22°C	51%	Sam Cheng

Test Item	Temperature	Humidity	Pressure	Tested By
ESD	19°C	53%	1008hPa	Chengkai Yin
RS	17°C	49%	1	Nick Liu
EFT	20°C	47%	/	Payton zhang
Surge	20°C	47%	/	Payton zhang
CS	22°C	51%	1	Sam Cheng
Dip	20°C	47%	1	Payton zhang



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Equipment	Children ride on toys
Brand Name	N/A
Test Model	TR1905
Series Model	N/A
Model Difference(s)	N/A
Power Source	DC voltage supplied from AC/DC adapter. Battery supply(only for the remote control)
Power Rating	I/P: 100-240V ~ 50/60Hz O/P: 12V===1000mA
Connecting I/O Port(s)	1* DC port 1* USB port 1* Audio port 1* SD card slot
Category of EUT	Category II Category III

Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the user's manual.



2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	FULL SYSTEM(Charging)
Mode 2	FULL SYSTEM(Forward)
Mode 3	FULL SYSTEM(Reverses)

Continuous Disturbance voltage/current test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)

Radiated disturbances test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)
Mode 2	FULL SYSTEM(Forward)
Mode 3	FULL SYSTEM(Reverses)

Harmonics / Flicker test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)

ESD test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)
Mode 2	FULL SYSTEM(Forward)
Mode 3	FULL SYSTEM(Reverses)

RS test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)
Mode 2	FULL SYSTEM(Forward)
Mode 3	FULL SYSTEM(Reverses)



EFT test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)

Surge test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)

CS test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)

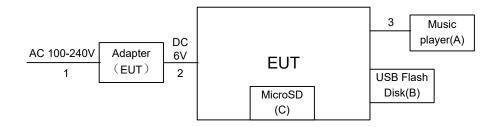
Dips test	
Final Test Mode	Description
Mode 1	FULL SYSTEM(Charging)

2.3 EUT OPERATING CONDITIONS

The EUT exercise program used during radiated and/or conducted emission measurement was designed to exercise the various system components in a manner similar to a typical use. The standard test signals and output signal as following:

- 1. EUT connected to music player via audio cable.
- 2. Micro SD is plugged into the EUT.
- 3. USB ~ input from a USB storage device.

2.4 BLOCK DIAGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED



Ground Plane

Remote System



2.5 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	Series No.
Α	Music player	Apple	A1446	DCYTMOVTGK64
В	USB Flash Disk	Kingston	DTSE9G2	WXX1E7405LYS
С	Micro SD	Kingston	N/A	N/A

Item	Cable Type	Shielded Type	Ferrite Core	Length
1	AC Cable	NO	NO	1.8m
2	DC Cable	NO	NO	1.5m
3	Audio Cable	YES	NO	1.5m



3. EMC EMISSION TEST

3.1 TERMINAL DISTURBANCE VOLTAGES TEST

3.1.1 LIMITS

General limits

Frequency	Mains ports Disturbance voltage		Associated ports			
range			Disturbance voltage		Disturbance current	
1	2	3	4	5	6	7
MHz	Quasi-peak dBμV	Average dBμV	Quasi-peak dBμV	Average dBμV	Quasi-peak dBμA	Average dBμA
0,15 to 0,50	Decreasing linearly with the logarithm 0,15 to 0,50 of the frequency from:		80	70	Decreasing linearly with th logarithm of the frequency from:	
	66 to 56	59 to 46			40 to 30	30 to 20
0,50 to 5	56 46		74	64	30	20
5 to 30	60	50	74	64] 30	20

The lower limit applies at the transition frequencies.

The test report shall state which test method was used and which limits were applied.

Limits for mains port of tools

Frequency range	<i>P</i> ≤ 700 W		700 W < P ≤ 1 000 W		P > 1 000 W	
1	2	3	4	5	6	7
MHz	Quasi-peak dBμV	Average dBμV	Quasi-peak dBμV	Average dBμV	Quasi-peak dBμV	Average dBμV
0,15 to 0,35	Decreasing linearly with the logarithm of the frequency from:					
0,15 to 0,35	66 to 59	59 to 49	70 to 63	63 to 53	76 to 69	69 to 59
0,35 to 5	59	49	63	53	69	59
5 to 30	64	54	68	58	74	64

The lower limit applies at the transition frequencies.

Key

P = rated power of the motor only.



3.1.2 TEST PROCEDURE

3.1.2.1 CONTINUOUS DISTURBANCE VOLTAGE/CURRENT FOR MAINS PORT

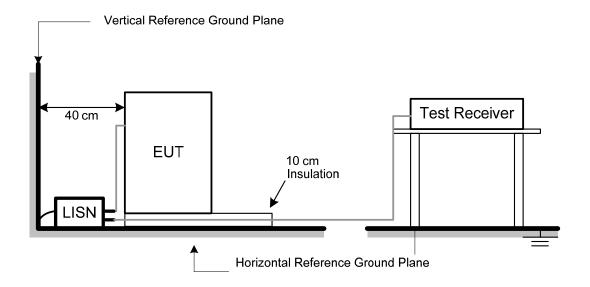
- a. The EUT was placed 0.1 meter thickness from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipment powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
 - If the equipment requires a dedicated ground connection, this shall be provided and bonded to the RGP. Mains cabling shall drape vertically to (but be insulated from) the horizontal RGP.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item -EUT Test Photos.

3.1.3 DEVIATION FROM TEST STANDARD

No deviation

3.1.4 TEST SETUP

CONTINUOUS DISTURBANCE VOLTAGE/CURRENT FOR MAINS PORT



3.1.5 TEST RESULTS

Please refer to the Appendix A.



3.2 RADIATED DISTURBANCES TEST

3.2.1 LIMITS

Testing method	Basic standard	Frequency range MHz	Limit ^a Quasi-peak dBµV/m	Remarks
OATS or SAC b	CISPR 16-2-3	30 to 230 230 to 1 000	30 37	Measurement distance 10 m
FAR ^C	CISPR 16-2-3	30 to 230 230 to 1 000	42 to 35 ^d 42	Measurement distance 3 m
FAR ^C	IEC 61000-4-22	30 to 230 230 to 1 000	42 to 35 ^d 42	Measurement distance 3 m
TEM- Waveguide ^e	IEC 61000-4-20	30 – 230 230 – 1 000	30 37	-

a The lower limit is applies at the transition frequency.

The test report shall state which test method was used and which limits were applied.

Table 3

Notes:

(1) The test result calculated as following: Measurement Value = Reading Level + Correct Factor Correct Factor = Antenna Factor + Cable Loss – Amplifier Gain(if use) Margin Level = Measurement Value – Limit Value

Measurements may be made at closer distance, down to 3 m. An inverse proportionality factor of 20 dB per decade shall be used to normalize the measured data to the specified distance for determining the limit. in this case the recommendations of the CISPR basic standards shall be considered when testing large EUT at frequency approaching 30 MHz, due to near field effects.

C All equipment shall be measured within the test volume as described in 5.3.4.3 and shown in Figures 12 to 19.

d Decreasing linearly with the logarithm of the frequency.

The TEM waveguide method shall be limited to battery operated EUT without cables attached and with a maximum size according to 6.2 of IEC 61000-4-20:2010 (the largest dimension of the enclosure is equal to the wavelength at the maximum measurement frequency, 300 mm at 1 GHz).



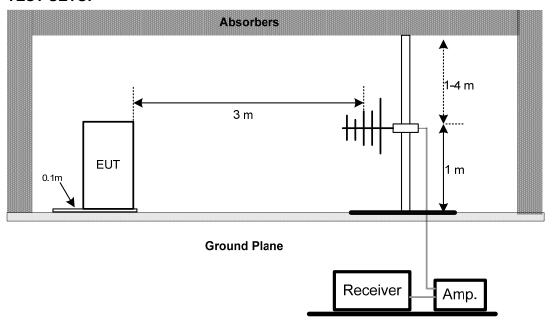
3.2.2 TEST PROCEDURE

- a. The measuring distance of 3 m shall be used for measurements. The EUT was placed on the top of a thickness 0.1 meter above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The height of the equipment or of the substitution antenna shall be 0.8 m, the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- c. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights find the maximum reading (used Bore sight function).
- d. The initial step in collecting radiated emission data is a receiver peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- e. All readings are Peak unless otherwise stated QP in column of Note. Peak denotes that the Peak reading compliance with the QP Limits and then QP Mode measurement didn't perform.
- f. For the actual test configuration, please refer to the related Item -EUT Test Photos.

3.2.3 DEVIATION FROM TEST STANDARD

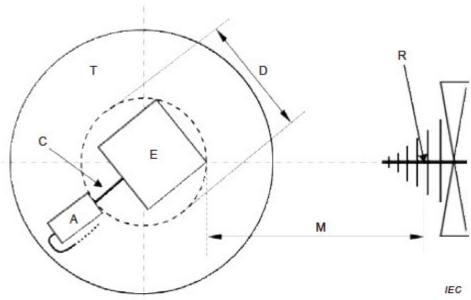
No deviation

3.2.4 TEST SETUP





3.2.5 MEASUREMENT DISTANCE



Mode Absorption Device

Figure 1 – Radiated emission – Location of the EUT on the turntable and measuring distance

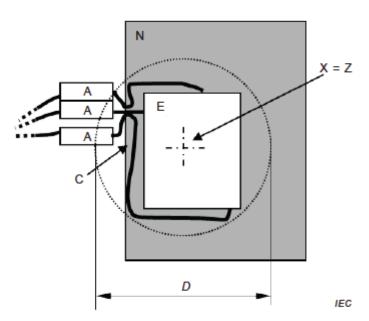


Figure 2 – Radiated emission – Example of test set-up for table-top EUT (top view)

3.2.6 TEST RESULTS

Please refer to the Appendix B.



3.3 HARMONIC CURRENT EMISSIONS TEST

3.3.1 LIMITS

	EN 61000-3-2						
Equipment Category	Harmonic Order	Max. Permissible Harmonic Current					
	n	A					
	Odd Har	rmonics					
	3	2.30					
	5	1.14					
	7	0.77					
	9	0.40					
	11	0.33					
Class A	13	0.21					
	15≤n≤39	0.15 x 15/n					
	Even Harmonics						
	2	1.08					
	4	0.43					
	6	0.30					
	8≤n≤40	0.23 x 8/n					

3.3.2 TEST PROCEDURE

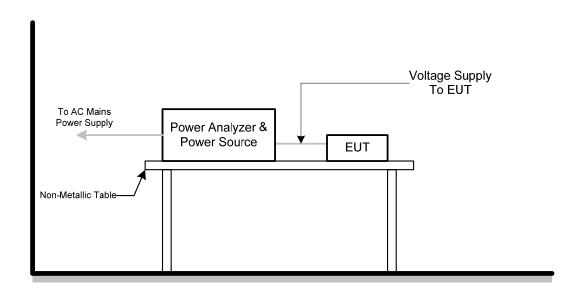
- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions.
- b. The classification of EUT is according to of EN 61000-3-2. The EUT is classified as Class A.
- c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

3.3.3 DEVIATION FROM TEST STANDARD

No deviation



3.3.4 TEST SETUP



3.3.5 TEST RESULTS

Please refer to the Appendix C.



3.4 VOLTAGE CHANGES, VOLTAGE FLUCTUATIONS AND FLICKER TEST

3.4.1 LIMITS

Tests	Limits EN 61000-3-3	Descriptions
Pst	≤ 1.0, Tp= 10 min.	Short Term Flicker Indicator
Plt	≤ 0.65, Tp=2 hr.	Long Term Flicker Indicator
dc	≤ 3.3%	Relative Steady-State V-Chang
dmax	≤ 4 %	Maximum Relative V-change
d (t)	≤ 500 ms	Relative V-change characteristic

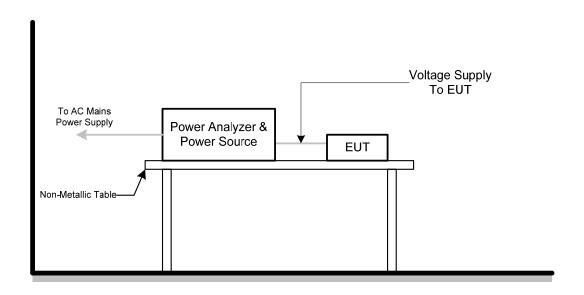
3.4.2 TEST PROCEDURE

- a. Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in EN 61000-3-3 depend on which standard adopted for compliance measurement.
- b. All types of harmonic current and/or voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

3.4.3 DEVIATION FROM TEST STANDARD

No deviation

3.4.4 TESTSETUP



3.4.5 TEST RESULTS

Please refer to the Appendix D.



4. EMC IMMUNITY TEST

4.1 APPLICABILITY OF TEST ITEMS

According to EN 55014-2 standard, the general performance criteria as following:

	Classification			
Category I	Category II	Category III	Category IV	Basic Standard
()	(√)	(√)	()	
N/A	$\sqrt{}$	$\sqrt{}$	$\sqrt{}$	IEC 61000-4-2
N/A	N/A	√ Note(1)	V	IEC 61000-4-3: (RS)
N/A	√	N/A	$\sqrt{}$	IEC 61000-4-4
N/A	√	N/A	√	IEC 61000-4-5
N/A	√	N/A	N/A	IEC 61000-4-6:(up to 230 MHz)
N/A	N/A	N/A	√	IEC 61000-4-6:(up to 80 MHz)
N/A	√	N/A	V	IEC 61000-4-11:

Remark: "N/A" denotes test is not applicable in this Test Report

Note(1): This test is only applicable to the ride on toys operating with electronic devices.

Category I: apparatus containing no electronic control circuitry.

Category II: transformer toys, dual supply toys, mains powered motor operated appliances, tools, heating appliances and similar electric apparatus (for example – UV radiators, IR radiators and microwave ovens) containing electronic control circuitry with no clock frequency higher than 15 MHz.

Category III: equipment which in normal use, is not connected to a power network and has no cables attached. However, this apparatus shall also be tested as an apparatus in category II while it is connected to the mains network.

Category IV: all other apparatus covered by the scope og this standard.

Criterion A	The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
Criterion B	The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
Criterion C	Temporary loss of function is allowed, provided the function is selfrecoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.



4.2 STANDARD COMPLIANCE/SERVRITY LEVEL/CRITERIA

Tests Standard No.	Test Specification Level	Test Mode Test Ports	Performance Criterion
Electrostatic discharge immunity	±8 kV air discharge ±4 kV contact discharge	Direct Mode	В
IEC 61000-4-2	±4 kV HCP discharge ±4 kV VCP discharge	Indirect Mode	В
Radiated, radio-frequency, electromagnetic field immunity IEC 61000-4-3	80 MHz to 1000 MHz 3 V/m(rms), 1 kHz, 80%, AM modulated	Enclosure	А
	±1.0 kV(peak) 5/50ns Tr/Th 5 kHz Repetition Freq.	AC Power Port	В
Electrical fast transient/burst immunity IEC 61000-4-4	±0.5 kV(peak) 5/50ns Tr/Th 5 kHz Repetition Freq.	DC Power Port (NOTE 1)	В
	±0.5 kV(peak) 5/50ns Tr/Th 5 kHz Repetition Freq.	CTL/Signal Data Line Port	В
Surge immunity	±1 kV(5P/5N) 1.2/50(8/20) Tr/Th us	L-N	В
IEC 61000-4-5	±2 kV(5P/5N) 1.2/50(8/20) Tr/Th us	L-PE N-PE	В
	0.15 MHz to 230 MHz 1 V(rms), 1 kHz 80%, AM Modulated 150Ω source impedance	CTL/Signal Port	А
Immunity to conducted disturbances, induced by radio-frequency fields IEC 61000-4-6	0.15 MHz to 230 MHz 3 V(rms), 1 kHz 80%, AM Modulated 150Ω source impedance	AC Power Port	А
Category II	0.15 MHz to 230 MHz 1 V(rms), 1 kHz 80%, AM Modulated 150Ω source impedance	DC Power Port (NOTE 1)	А
Voltage dips IEC 61000-4-11	Voltage Dips 30% Voltage Dips 60% Voltage>100%	AC Power Port	C C C

NOTE:

(1) If the cables may be longer than 3 m.



4.3 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

4.3.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Required Performance	В
Discharge Voltage:	Air Discharge: ±2 kV, ±4 kV, ±8 kV (Direct)
	Contact Discharge: ±2 kV, ±4 kV (Indirect)
Polarity:	Positive & Negative
Number of Discharge	20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1 second

4.3.2 TEST PROCEDURE

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a. The test shall be performed with single discharges. On each pre-selected point at least 10single discharges (in the most sensitive polarity) shall be applied.

NOTE 1 The minimum number of discharges applied is depending on the EUT; for products with synchronized circuits the number of discharges should be larger.

For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.

NOTE 2 The points to which the discharges should be applied may be selected by means of an explor ation carried out at a repetition rate of 20 discharges per second, or more. Vertical Coupling Plane (VCP):

The coupling plane, of dimensions $0.5m \times 0.5m$, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

- b. Air discharges at insulation surfaces of the EUT.
 - It was at least ten single discharges with positive and negative at the same selected point.
- c. For FLOOR-STANDING equipment:

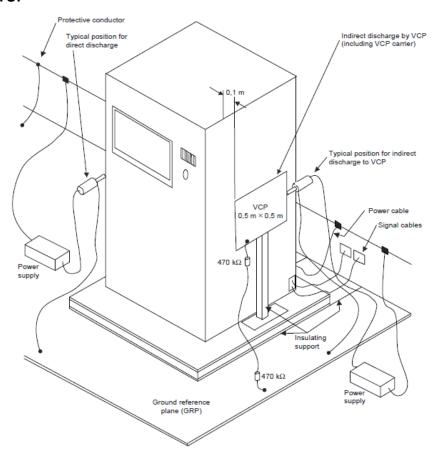
The equipment under test was installed in a representative system as described in EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1 meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



4.3.3 DEVIATION FROM TEST STANDARD

No deviation / The requirement followed by the client's specification.

4.3.4 TEST SETUP



4.3.5 TEST RESULTS

Please refer to the Appendix E.



4.4 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

4.4.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-3
Required Performance	A
Frequency Range:	80 MHz - 1000 MHz
Field Strength:	3 V/m, (unmodulated, r.m.s.)
Modulation:	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1% of fundamental
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Dwell Time:	3 seconds

4.4.2 TEST PROCEDURE

The EUT and support equipment are in a fully-anechoic chamber.

The testing distance from antenna to the EUT was 3 meters.

For FLOOR-STANDING equipment:

The EUT installed in a representative system as described in IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

The other condition as following manner:

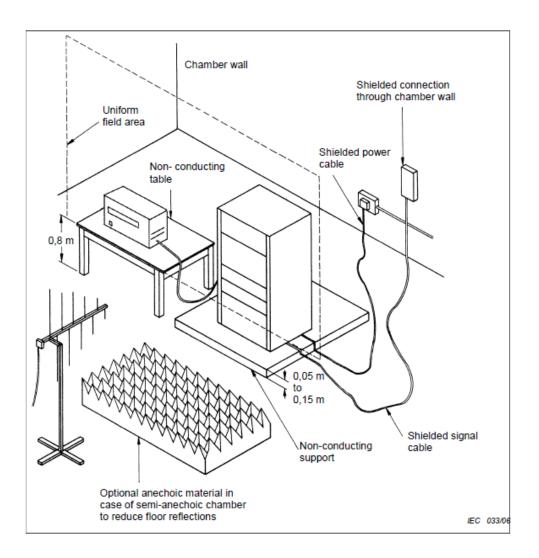
- a. The field strength level was 3 V/m(unmodulated, r.m.s).
- b. The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

4.4.3 DEVIATION FROM TEST STANDARD

No deviation.



4.4.4 TEST SETUP



4.4.5 TEST RESULTS

Please refer to the Appendix F.



4.5 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT/BURST)

4.5.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-4		
Required Performance	В		
Test Voltage	AC Power Ports: ±1 kV		
Polarity:	Positive & Negative		
Impulse Frequency:	5 kHz		
Impulse Wave shape :	5/50 ns		
Burst Duration:	15 ms		
Burst Period:	300 ms		
Test Duration:	2 min.		

4.5.2 TEST PROCEDURE

For FLOOR-STANDING equipment:

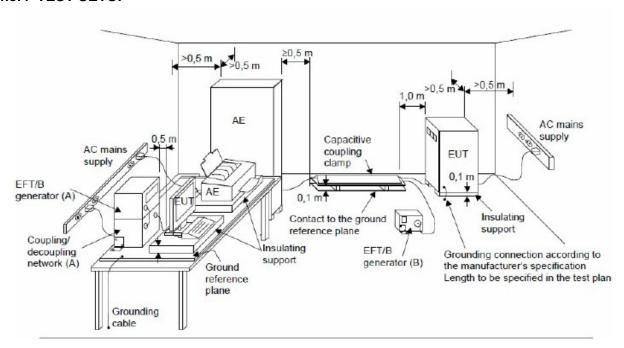
The EUT installed in a representative system as described in IEC 61000-4-4 and its cables were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. The other condition as following manner:

- a. Both positive and negative polarity discharges were applied.
- b. The duration time of each test sequential was 2 minute

4.5.3 DEVIATION FROM TEST STANDARD

No deviation / The requirement followed by the client's specification.

4.5.4 TEST SETUP



4.5.5 TEST RESULTS

Please refer to the Appendix G.



4.6 SURGE IMMUNITY TEST

4.6.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-5		
Required Performance	В		
Wave-Shape:	1.2/50(8/20) Tr/Th µs combination wave		
Test Voltage :	AC Power Port: ±1 kV		
Generator Source	2 Ω of the low-voltage power supply network.		
Impedance:			
Phase Angle:	AC Port: 90°/270°		
Pulse Repetition Rate:	1 time / min.		
Number of Tests:	5 positive and 5 negative at selected points		

4.6.2 TEST PROCEDURE

a. For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).

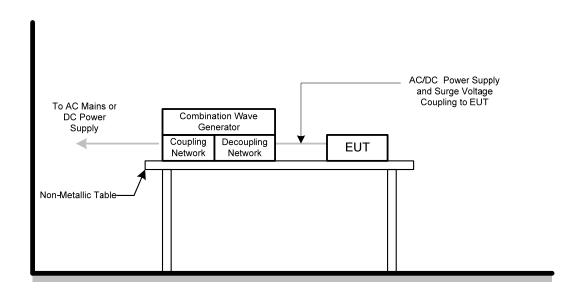
- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:
 - The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT: The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).



4.6.3 DEVIATION FROM TEST STANDARD

No deviation.

4.6.4 TEST SETUP



4.6.5 TEST RESULTS

Please refer to the Appendix H.



4.7 IMMUNITY TO CONDUCTED DISTURBANCES, INDUCED BY RADIO-FREQUENCY FIELDS TEST (CS)

4.7.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-6		
Required Performance	A		
Frequency Range:	0.15 MHz - 230 MHz		
Field Strength:	AC power ports: 3 V, (unmodulated, r.m.s.)		
	DC power ports: 1 V, (unmodulated, r.m.s.)		
	CTL/Signal/Data Line Port: 1 V, (unmodulated, r.m.s.)		
Modulation:	1 kHz Sine Wave, 80%, AM Modulation		
Frequency Step:	1% of fundamental		
Dwell Time:	3 seconds		

4.7.2 TEST PROCEDURE

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

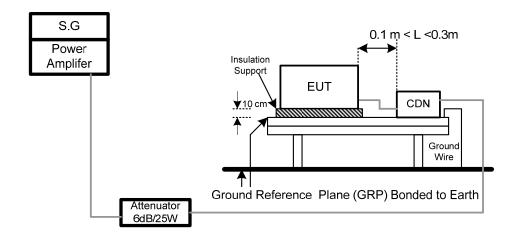
The other condition as following manner:

- a. The field strength level was 3 V, (unmodulated, r.m.s.).
- b. The frequency range is swept from 150 kHz to 80 MHz, with the signal 80%amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.

4.7.3 DEVIATION FROM TEST STANDARD

No deviation.

4.7.4 TEST SETUP



4.7.5 TEST RESULTS

Please refer to the Appendix I.



4.8 VOLTAGE DIPS IMMUNITY TEST

4.8.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-11
Required Performance	C (For 30% Voltage Dips)
	C (For 60% Voltage Dips)
	C (For 100% Voltage Dips)
Interval between Event:	Ten seconds
Phase Angle:	0°/180°
Test Cycle:	3 times

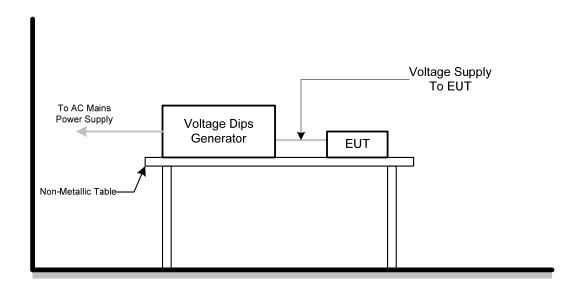
4.8.2 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

4.8.3 DEVIATION FROM TEST STANDARD

No deviation.

4.8.4 TEST SETUP



4.8.5 TEST RESULTS

Please refer to the Appendix J.



5. MEASUREMENT INSTRUMENTS LIST

	Continuous Disturbance voltage/current					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	Line Impedance Stabilisation Network	Schwarzbeck	NNLK 8121	8121-822	Mar. 29, 2020	
2	TWO-LINE V-NETWORK	R&S	ENV216	101340	Sep. 01, 2020	
3	Test Cable	emci	EMCRG400-BM-N M-10000	170628	Jul. 15, 2020	
4	EMI Test Receiver	R&S	ESCI	100082	Mar. 29, 2020	
5	50Ω Terminator	SHX	TF2-1G-A	17051602	Mar. 29, 2020	
6	50Ω coaxial switch	Anritsu	MP59B	6201750902	Mar. 29, 2020	
7	Measurement Software	Farad	EZ-EMC Ver.NB-03A1-01	N/A	N/A	

	Radiated disturbances						
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until		
1	TRILOG Broadband Antenna	Schwarzbeck	VULB 9168	719	Mar. 29, 2020		
2	Pre-Amplifier	emci	EMC9135	980400	Mar. 29, 2020		
3	MXE EMI Receiver	Keysight	N9038A	MY56400088	Mar. 29, 2020		
4	Test Cable	emci	EMC104-SM-SM-7 000	170330	Apr. 16, 2020		
5	Test Cable	emci	EMC104-SM-SM-1 000	170331	Apr. 16, 2020		
6	Test Cable	emci	EMC104-SM-NM-3 500	170621	Apr. 16, 2020		
7	Measurement Software	Farad	EZ-EMC Ver.NB-03A1-01	N/A	N/A		

Harmonics & Flickers					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	3 kVA single Phase Harmonics & Flicker Measuring System	Teseq	ProfLine 2103	1705A04171	Sep. 01, 2020
2	Measurement Software	California	CTS4 Version 4.23.0	N/A	N/A

	ESD					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	ESD Simulator	Teseq	NSG 437	1133	Mar. 21, 2020	



	RS					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	Microwave LogPer. Antenna	Schwarzbeck	STLP 9129	9129 027	Mar. 21, 2020	
2	Radiated Immunity test system	Teseq	ITS 6006	37668	Sep. 07, 2020	
3	RF Switch network	Teseq	RFB 2000	45816	N/A	
4	Power meter	Teseq	PM 6006	75508	Sep. 07, 2020	
5	Power meter	Teseq	PM 6006	75509	Sep. 07, 2020	
6	40dB Dual Directional Coupler	Werlatone	C5982-10	112687	N/A	
7	40dB Dual directional coupler	Werlatone	C10117-10	112805	N/A	
8	Power Amplifier	MILMEGA	80RF1000-300	1078551	Sep. 07, 2020	
9	Power Amplifier	MILMEGA	AS0860-50/50	1078552	Sep. 07, 2020	
10	Test Cable	emci	S10172B	N/A	N/A	
11	Test Cable	emci	S10172B	N/A	N/A	
12	Test Cable	emci	RG214/U	N/A	N/A	
13	Test Cable	emci	S10172B	N/A	N/A	
14	Measurement Software	AUDIX	i2 20170414a Ver5	N/A	N/A	

	EFT					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	4055	Oct. 11, 2020	
2	Measurement Software	Teseq	Win 3000 Version 1.3.2	N/A	N/A	



Surge					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	4055	Oct. 11, 2020
2	Measurement Software	Teseq	Win 3000 Version 1.3.2	N/A	N/A

	cs					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	Compact immunity test system	Teseq	NSG 4070B-35	45751	Sep. 01, 2020	
2	Attenuator	Teseq	ATN 6050	16121502	Sep. 07, 2020	
3	50Ω Terminator	SHX	TF2-1G-A	17051603	Mar. 29, 2020	
4	Measurement Software	Teseq	NSG 4070 Version 1.3.0.1	N/A	N/A	
5	CDN	Teseq	CDN M016S	45669	Sep. 01, 2020	

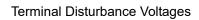
DIPS					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	4055	Oct. 11, 2020
2	Measurement Software	Teseq	Win 3000 Version 1.3.2	N/A	N/A

Remark: "N/A" denotes no model name, serial no. or calibration specified.

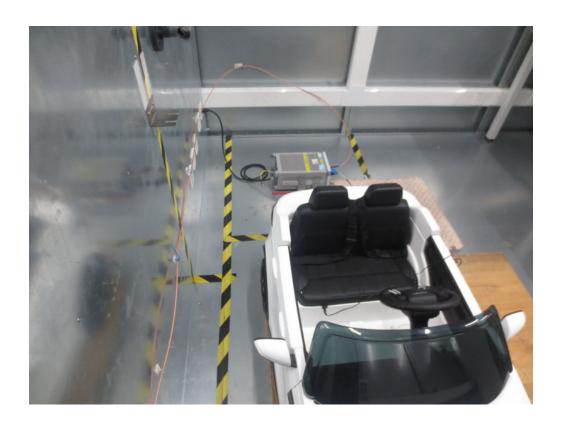
All calibration period of equipment list is one year.



6. EUT TEST PHOTO



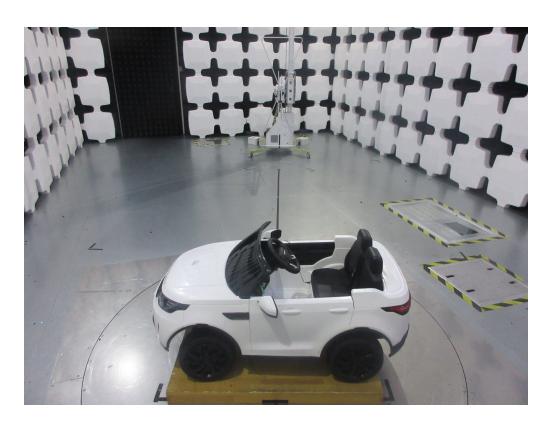










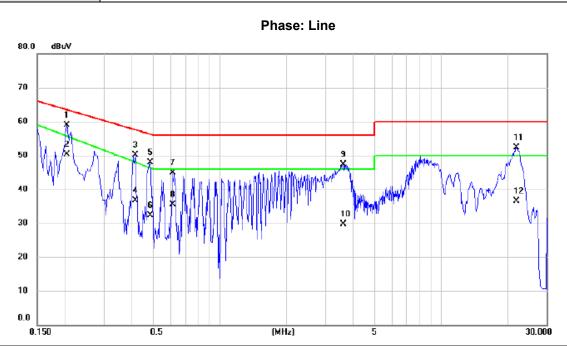




APPENDIX A - CONTINUOUS DISTURBANCE VOLTAGE/CURRENT



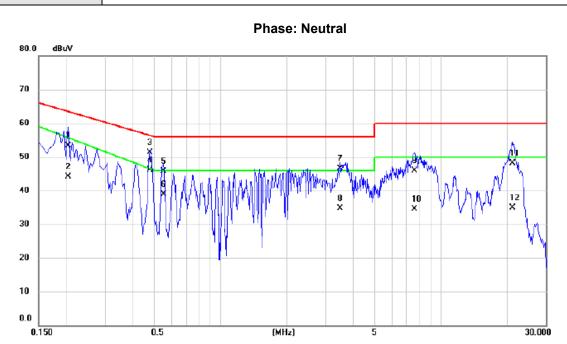
Test Voltage :	AC 230V/50Hz
Test Mode	Mode 1



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBu∨	dB	dBuV	dBu∀	dB	Detector	Comment
1	*	0.2040	49.18	9.82	59.00	63.45	-4.45	QP	
2		0.2040	40.50	9.82	50.32	55.68	-5.36	AVG	
3		0.4155	40.26	9.90	50.16	57.54	-7.38	QP	
4		0.4155	26.80	9.90	36.70	48.00	-11.30	AVG	
5		0.4875	37.90	9.99	47.89	56.21	-8.32	QP	
6		0.4875	22.30	9.99	32.29	46.27	-13.98	AVG	
7		0.6134	34.95	10.00	44.95	56.00	-11.05	QP	
8		0.6134	25.50	10.00	35.50	46.00	-10.50	AVG	
9		3.6060	37.27	10.03	47.30	56.00	-8.70	QP	
10		3.6060	19.60	10.03	29.63	46.00	-16.37	AVG	
11		21.9074	41.91	10.38	52.29	60.00	-7.71	QP	
12		21.9074	26.10	10.38	36.48	50.00	-13.52	AVG	



Test Voltage :	AC 230V/50Hz
Test Mode	Mode 1



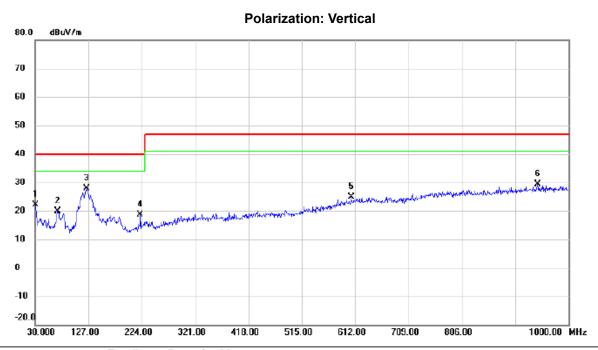
No. MI	k. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
	MHz	dBu∀	dB	dBuV	dBu∀	dB	Detector	Comment
1	0.2040	43.70	9.66	53.36	63.45	-10.09	QP	
2	0.2040	34.40	9.66	44.06	55.68	-11.62	AVG	
3	0.4785	41.40	9.81	51.21	56.37	-5.16	QP	
4 *	0.4785	36.30	9.81	46.11	46.47	-0.36	AVG	
5	0.5505	35.90	9.85	45.75	56.00	-10.25	QP	
6	0.5505	29.10	9.85	38.95	46.00	-7.05	AVG	
7	3.4935	36.40	10.03	46.43	56.00	-9.57	QP	
8	3.4935	24.70	10.03	34.73	46.00	-11.27	AVG	
9	7.5705	35.80	10.14	45.94	60.00	-14.06	QP	
10	7.5705	24.40	10.14	34.54	50.00	-15.46	AVG	
11	21.1875	37.90	10.12	48.02	60.00	-11.98	QP	
12	21.1875	24.70	10.12	34.82	50.00	-15.18	AVG	



APPENDIX B - RADIATED DISTURBANCES



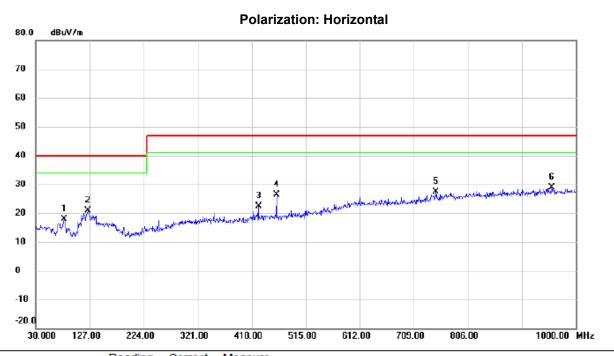
Test Voltage	AC 230V/50Hz
Test Mode	Mode 1



No	. Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		30.0000	39.49	-17.34	22.15	40.00	-17.85	QP	
2		70.7400	39.19	-19.41	19.78	40.00	-20.22	QP	
3	*	123.1200	44.97	-17.02	27.95	40.00	-12.05	QP	
4		221.0900	36.41	-17.90	18.51	40.00	-21.49	QP	
5		604.2400	33.58	-8.64	24.94	47.00	-22.06	QP	
6		943.7400	34.54	-5.18	29.36	47.00	-17.64	QP	



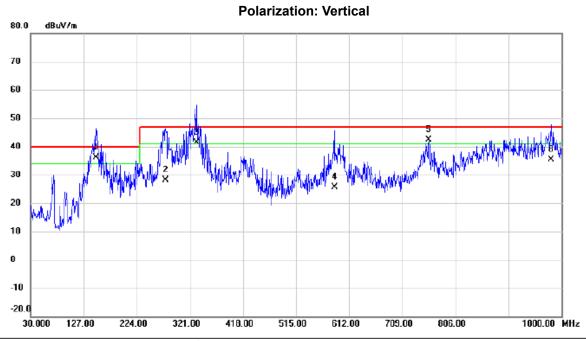
Test Voltage	AC 230V/50Hz
Test Mode	Mode 1



	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
_			MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
_	1		81.4100	38.23	-20.32	17.91	40.00	-22.09	QP	
	2	1	24.0900	37.83	-17.00	20.83	40.00	-19.17	QP	
_	3	4	129.6400	35.26	-12.97	22.29	47.00	-24.71	QP	
_	4	4	162.6200	39.38	-12.91	26.47	47.00	-20.53	QP	
	5	7	748.7700	34.02	-6.71	27.31	47.00	-19.69	QP	
_	6	* 0	956.3500	33.98	-5.11	28.87	47.00	-18.13	QP	



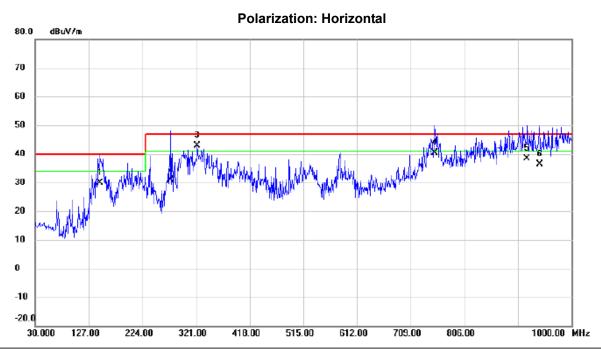
Test Voltage	DC 15V
Test Mode	Mode 2



	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
-			MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
-	1	*	149.3100	51.07	-14.87	36.20	40.00	-3.80	QP	
Ī	2		276.3800	43.55	-15.34	28.21	47.00	-18.79	QP	
Ī	3	İ	332.6400	55.13	-13.85	41.28	47.00	-5.72	QP	
Ī	4		584.8400	35.16	-9.43	25.73	47.00	-21.27	QP	
-	5	İ	757.5000	48.93	-6.63	42.30	47.00	-4.70	QP	
	6		980.6000	40.35	-4.98	35.37	47.00	-11.63	QP	



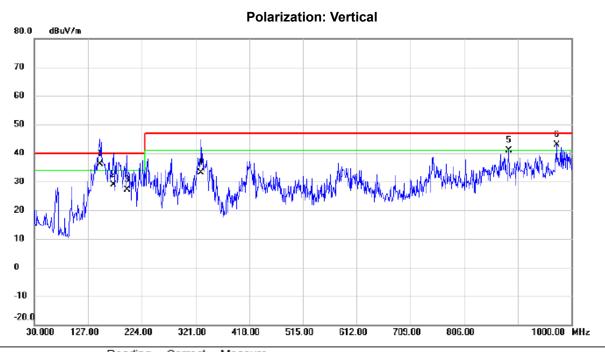
Test Voltage	DC 15V
Test Mode	Mode 2



	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
_			MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1		147.3700	44.82	-15.04	29.78	40.00	-10.22	QP	
_	2		275.4100	46.35	-15.42	30.93	47.00	-16.07	QP	
_	3	*	322.9400	56.89	-13.97	42.92	47.00	-4.08	QP	
_	4		752.6500	47.08	-6.65	40.43	47.00	-6.57	QP	
_	5		919.4900	43.68	-5.31	38.37	47.00	-8.63	QP	
_	6		941.8000	41.56	-5.19	36.37	47.00	-10.63	QP	



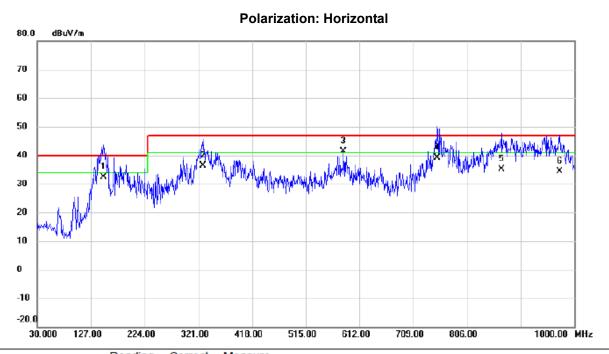
Test Voltage	DC 15V
Test Mode	Mode 3



No). N	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
			MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1 *	* 1	48.3400	51.06	-14.94	36.12	40.00	-3.88	QP	
2	2	1	72.5900	44.96	-16.09	28.87	40.00	-11.13	QP	
3	3	1	96.8400	45.73	-18.72	27.01	40.00	-12.99	QP	
4	1	3	330.7000	47.00	-13.88	33.12	47.00	-13.88	QP	
	5	8	886.5100	46.49	-5.58	40.91	47.00	-6.09	QP	
(6 !	! 9	72.8400	47.80	-5.02	42.78	47.00	-4.22	QP	



Test Voltage	DC 15V
Test Mode	Mode 3



	No.	Mk.	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
			MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1		149.3100	47.29	-14.87	32.42	40.00	-7.58	QP	
-	2		329.7300	50.34	-13.89	36.45	47.00	-10.55	QP	
-	3	*	582.9000	50.87	-9.53	41.34	47.00	-5.66	QP	
-	4		751.6800	45.74	-6.66	39.08	47.00	-7.92	QP	
-	5		868.0800	41.04	-5.81	35.23	47.00	-11.77	QP	
-	6		973.8100	39.40	-5.02	34.38	47.00	-12.62	QP	

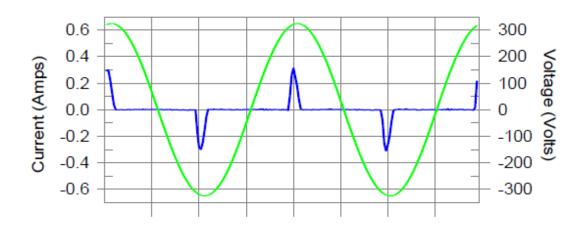


APPENDIX C - HARMONICS CURRENT

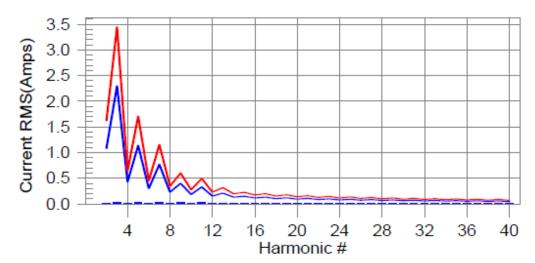


	Harmonics – Class A
Test Voltage	AC 230V/50Hz
Test Mode	Mode 1

Current & voltage waveforms



Harmonics and Class A limit line European Limits



Test result: Pass Worst harmonics H15-6.0% of 150% limit, H15-8.9% of 100% limit



	Current Test Result Summary (Run time)
Test Voltage	AC 230V/50Hz
Test Mode	Mode 1

Highest parameter values during test:

V RMS (Volts): 229.69

I Peak (Amps): 0.328

I Fund (Amps): 0.034

Power (Watts): 7.7 Frequency(Hz): 50.00 I RMS (Amps): 0.076 Crest Factor: 4.394 Power Factor: 0.447

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	1.080	N/A	0.001	1.620	N/A	Pass
2 3	0.032	2.300	1.4	0.033	3.450	1.0	Pass
4	0.001	0.430	N/A	0.001	0.645	N/A	Pass
5	0.031	1.140	2.7	0.031	1.710	1.8	Pass
4 5 6 7	0.000	0.300	N/A	0.001	0.450	N/A	Pass
7	0.028	0.770	3.6	0.028	1.155	2.5	Pass
8	0.000	0.230	N/A	0.000	0.345	N/A	Pass
9	0.025	0.400	6.2	0.025	0.600	4.2	Pass
10	0.000	0.184	N/A	0.000	0.276	N/A	Pass
11	0.021	0.330	6.4	0.021	0.495	4.3	Pass
12	0.000	0.153	N/A	0.000	0.230	N/A	Pass
13	0.017	0.210	8.2	0.017	0.315	5.5	Pass
14	0.000	0.131	N/A	0.000	0.197	N/A	Pass
15	0.013	0.150	8.9	0.013	0.225	6.0	Pass
16	0.000	0.115	N/A	0.000	0.173	N/A	Pass
17	0.010	0.132	7.5	0.010	0.198	5.0	Pass
18	0.000	0.102	N/A	0.000	0.153	N/A	Pass
19	0.007	0.118	5.8	0.007	0.178	3.9	Pass
20	0.000	0.092	N/A	0.002	0.138	N/A	Pass
21	0.005	0.107	N/A	0.005	0.161	N/A	Pass
22	0.000	0.084	N/A	0.000	0.125	N/A	Pass
23	0.003	0.098	N/A	0.003	0.147	N/A	Pass
24	0.000	0.077	N/A	0.000	0.115	N/A	Pass
25 26	0.003 0.000	0.090 0.071	N/A N/A	0.003 0.000	0.135 0.107	N/A N/A	Pass
27	0.003	0.083	N/A N/A	0.003	0.107	N/A	Pass Pass
28	0.003	0.066	N/A N/A	0.003	0.099	N/A	
29	0.004	0.000	N/A N/A	0.004	0.033	N/A	Pass Pass
30	0.004	0.078	N/A N/A	0.004	0.092	N/A	Pass
31	0.003	0.073	N/A	0.003	0.109	N/A	Pass
32	0.003	0.058	N/A	0.000	0.086	N/A	Pass
33	0.003	0.058	N/A	0.003	0.102	N/A	Pass
34	0.000	0.054	N/A	0.000	0.081	N/A	Pass
35	0.002	0.064	N/A	0.002	0.096	N/A	Pass
36	0.002	0.051	N/A	0.002	0.077	N/A	Pass
37	0.002	0.061	N/A	0.002	0.091	N/A	Pass
38	0.000	0.048	N/A	0.000	0.073	N/A	Pass
39	0.001	0.058	N/A	0.001	0.087	N/A	Pass
40	0.000	0.046	N/A	0.000	0.069	N/A	Pass



	Voltage Source Verification Data (Run time)
Test Voltage	AC 230V/50Hz
Test Mode	Mode 1

Highest parameter values during test:
Voltage (Vrms): 229.69
I Peak (Amps): 0.328
I Fund (Amps): 0.034
Power (Watts): 7.7 Frequency(Hz): 50.00 I RMS (Amps): 0.076 Crest Factor: 4.394 Power Factor: 0.447

Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2	0.069	0.459	14.95	OK
3	0.428	2.067	20.70	OK
4	0.031	0.459	6.70	OK
5	0.023	0.919	2.47	OK
<u>6</u>	0.019	0.459	4.03	OK
2 3 4 5 6 7 8 9	0.031	0.689	4.53	OK
8	0.011	0.459	2.33	OK
10	0.018	0.459	3.92	OK
10	0.016 0.018	0.459 0.230	3.48 7.98	OK OK
12	0.018	0.230	5.48	OK
13	0.013	0.230	6.12	OK
14	0.005	0.230	2.01	OK OK
15	0.010	0.230	4.48	OK
16	0.008	0.230	3.38	OK
17	0.011	0.230	4.85	ŏĸ
18	0.008	0.230	3.47	ŏĸ
19	0.013	0.230	5.49	ŏĸ
20	0.009	0.230	3.82	ΟK
21	0.007	0.230	3.27	OK
22	0.003	0.230	1.46	OK
23	0.006	0.230	2.81	OK
24	0.004	0.230	1.93	OK
25	0.006	0.230	2.80	OK
26	0.003	0.230	1.23	OK
27	0.010	0.230	4.28	OK
28	0.003	0.230	1.43	oĸ
29	0.006	0.230	2.53	OK
30	0.004	0.230	1.96	OK
31	0.007	0.230	2.83	OK
32	0.003	0.230	1.43	OK
33 34	0.006	0.230	2.62	OK OK
35	0.002 0.005	0.230 0.230	0.96 2.38	OK
36	0.003	0.230	1.31	OK
37	0.005	0.230	2.46	OK
38	0.002	0.230	0.98	Ŏ K
39	0.002	0.230	2.49	OK
40	0.007	0.230	2.97	ŎΚ



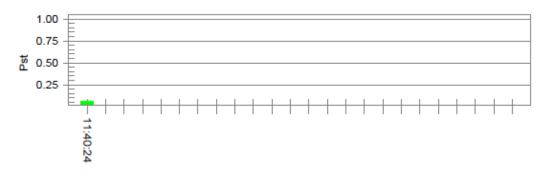
APPENDIX D - VOLTAGE FLUCTUATION AND FLICKER



Test Voltage	AC 230V/50Hz
Test Mode	Mode 1

Pst_I and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:

vrms at the end of test (voit):	229.60			
T-max (mS):	0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.00	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.064	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.028	Test limit:	0.650	Pass



APPENDIX E - ESD



Test Voltage	AC 230V/50Hz	DC 15V
Test Mode	Mode 1	Mode 2/ Mode 3

Mode		Air Discharge					Contact Discharge							
	21	۲V	41	۲V	8	kV	- [kV	2k	V	41	۲V	- k	٧V
Location	Р	N	Р	N	Р	N	Р	N	Р	N	Р	N	Р	Ν
1	Α	Α	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
2	Α	Α	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
3	Α	Α	Α	Α	Α	Α	-	-	-	-	-	-	-	-
4	Α	Α	Α	Α	Α	Α	-	-	-	-	-	-	-	-
5	Α	Α	Α	Α	Α	Α	-	-	-	-	-	-	-	-
6	Α	Α	Α	Α	Α	Α	-	-	-	-	-	-	-	-
7	Α	Α	Α	Α	Α	Α	-	-	-	-	-	-	-	-
Criteria	В				- B									
Result		•		4		•		-	Α					

Mode	HCP Contact Discharge					VCP Contact Discharge						
	2kV		4kV		- kV		2kV		4kV		- kV	
Location	Р	N	Р	N	Р	N	Р	N	Р	N	Р	N
Left side	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
Right side	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
Front side	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
Rear side	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
Criteria	В			-		В					-	
Result	Α				-	A			,	-		

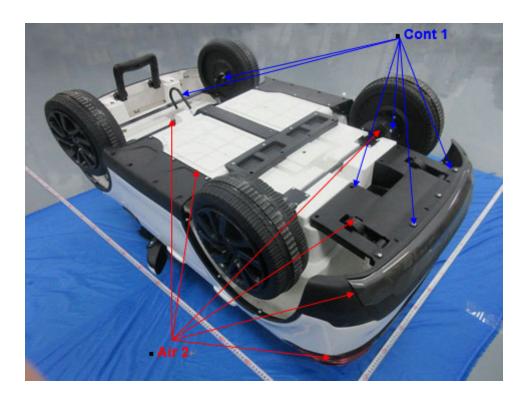
Note:

- 1) P/N denotes the Positive/Negative polarity of the output voltage.
- 2) N/A denotes test is not applicable in this test report

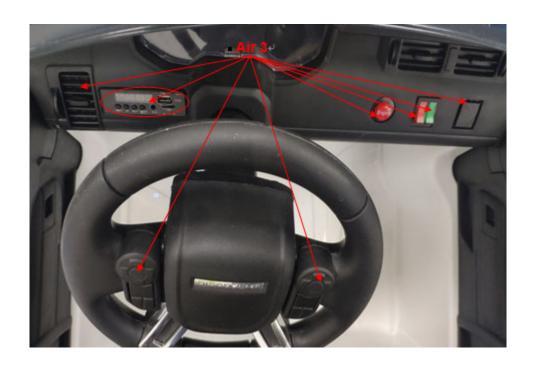


PHOTO(S) SHOWN THE LOCATION(S) OF ESD EVALUATED





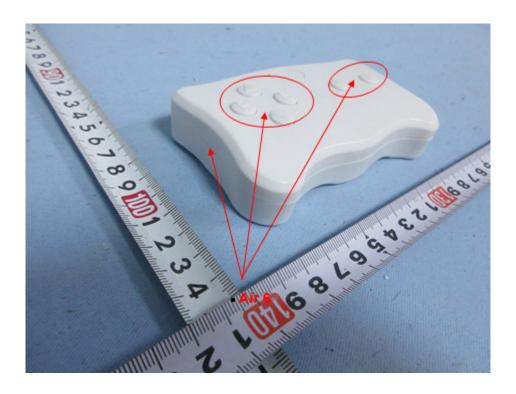




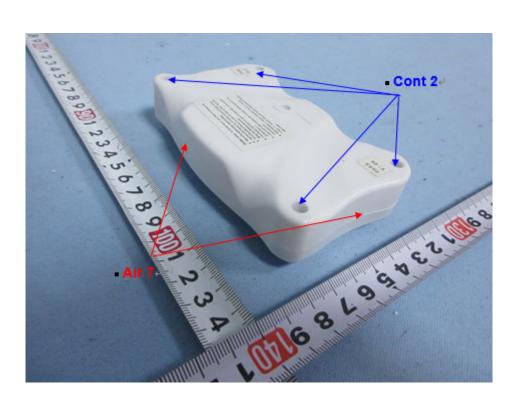














APPENDIX F - RS



Test Voltage	AC 230V/50Hz	DC 15V
Test Mode	Mode 1	Mode 2/ Mode 3

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Modulation	Azimuth	Criterion	Result
				0		
90 1000	H/V	2\//m	AM Modulated	90	Α	۸
80 - 1000		3V/m	1000Hz, 80%	180		Α
				270		



APPENDIX G - EFT/BURST

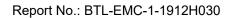


Test Voltage	AC 230V/50Hz
Test Mode	Mode 1

EUT Port	s Tested	Polarity	Repetition Frequency	Test Level 1kV	Criterion	Result	
	Lino (L)	+	5 kHz	Α	В	Δ.	
	Line (L)	-	5 kHz	Α	В	А	
AC Dower Dort	Neutral (N) L+N	+	5 kHz	Α	D	٨	
AC Power Port		-	5 kHz	Α	В	А	
		+	5 kHz	Α	В	۸	
		_	5 kHz	Α	D	А	



APPENDIX H - SURGE





Test Voltage :	AC 230V/50Hz
Test Mode :	Mode 1

\\/c	Wave Form		1.2/50(8/20)Ti/Th us								
	EUT Ports Tested	Polarity	Phase		Volt		Criteria	Results			
	EUT FOILS TESTEU	Polarity	riiase	1kV	-kV	-kV	-kV				
	I NI	+	90°	Α	-	-	-	В	^		
	L - N	-	270°	Α	-	-	•	Б	A		



APPENDIX I - INJECTION CURRENT

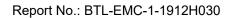


Test Voltage	AC 230V/50Hz
Test Mode	Mode 1

Test Ports (Mode)	Freq. Range (MHz)	Field Strength	Modulation	Perform. Criterion	Result
Input/ Output AC. Power Port		3 V		А	А
Input/ Output DC. Power Port	0.15 - 230	1 V	AM Modulated 1000 Hz 80%	А	N/A
Signal Line		1 V		А	N/A



APPENDIX J - VOLTAGE INTERRUPTION/DIPS





Test Voltage	AC 100V/50Hz, AC 230V/50Hz, AC 240V/50Hz
Test Mode	Mode 1

AC 100V/50Hz						
Item	Voltage Reduction	Duration (Periods)	Criterion	Result		
Voltage Dips	30%	25	С	А		
Voltage Dips	60%	10	С	А		
Voltage	100%	0.5	С	С		

AC 230V/50Hz						
ltem	Voltage Reduction	Duration (Periods)	Criterion	Result		
Voltage Dips	30%	25	С	А		
Voltage Dips	60%	10	С	А		
Voltage	100%	0.5	С	С		

AC 240V/50Hz						
Item	Voltage Reduction	Duration (Periods)	Criterion	Result		
Voltage Dips	30%	25	С	А		
Voltage Dips	60%	10	С	Α		
Voltage	100%	0.5	С	С		

End of Test Report